



INDIAN INSTITUTE OF TECHNOLOGY BOMBAY

MATERIALS MANAGEMENT DIVISION

Powai, Mumbai 400076.

Corrigendum - I

PR No. 1000051563

RFx No. 6100002541

Spectrofluorimeter with lifetime measurements

Sr. No	Online RFx Clause	Previous Clause	Modified Clause
1	Technical specification Sr. No. 1 Signal-to-Noise Ratio	$\geq 13,000:1$ (FSD) or better at 397 nm, 5-nm bandpass, 1-s integration time, background noise first standard deviation at 450 nm. Double-distilled, de-ionized Sensitivity must be measured with no optical filter, no smoothing, no repeat emission scan.	$\geq 12,000:1$ (FSD) or better at 397 nm, 5-nm bandpass, 1-s integration time, background noise first standard deviation at 450 nm. Double-distilled, de-ionized Sensitivity must be measured with no optical filter, no smoothing, no repeat emission scan
2	Technical specification Sr. No. 2 Excitation Source	b) 7 W or higher power Xenon pulse source for phosphorescence decay measurements.	b) 5 W or higher power Xenon pulse source for phosphorescence decay measurements.
3	Technical specification Sr. No. 12 TCSPC source	1. Pulsed LED with peak WL 340 ± 10 nm, repetition 2. Pulsed Laser with peak WL 375 ± 10 nm,	1. Pulsed LED with peak WL 340 ± 10 nm, repetition 20MHz or better 2. Pulsed Laser with peak WL 375 ± 10 nm,

		repetition rate 25MHz or better. 3. Pulsed Laser with peak WL 405 ± 10 nm, repetition rate 25MHz or better.	repetition rate 20MHz or better. 3. Pulsed Laser with peak WL 405 ± 10 nm, repetition rate 20MHz or better.
4	Bid Submission End Date / Date & Time of submission (Online RFX Clause)	05.01.2026 at 13:00	08.01.2026 at 13:00
5	Bid Opening Date & Time (Online RFX Clause)	05.01.2026 at 16:00	08.01.2026 at 16:00

Deepak Kumar
01/01/2026

Sahana
01/01/26

Asst. Registrar
Materials Management Division

①
11/26